

<b>Notice of References Cited</b>	Application/Control No. 10/598,090	Applicant(s)/Patent Under Reexamination NOHNO ET AL.	
	Examiner HEE-YONG KIM	Art Unit 2482	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,926,153 A	07-1999	Ohishi et al.	345/1.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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